Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination
09/674,347	VAN DER WAL ET AL.
Examiner	Art Unit

2616

Christine Ng

SEARCHED				
Class	Subclass	Date	Examiner	
370	230.1	12/11/2007	CN	
370	232	12/11/2007	CN	
370	233	12/11/2007	CN	
370	234	12/11/2007	CN	
370	252	12/11/2007	CN	
370	253	12/11/2007	CN	
370	395.1	12/11/2007	CN	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NO (INCLUDING SEARCH	STRATEGY)
	DATE	EXMR
Huy Vu	12/11/2007	CN
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